

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination YAMADA ET AL	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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FOREIGN PATENT DOCUMENTS

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	N	EP 0858171 A2	08-1998	EP	Yonemitsu et al	-----
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NON-PATENT DOCUMENTS

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